

N-Channel 30-V (D-S) MOSFET

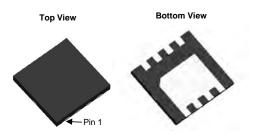
PRODUCT SUMMARY						
V _{DS} (V)	R _{DS(on)} (Ω)	I _D (A) ^a	Q _g (Typ.)			
30	0.010 at V $_{\rm GS}$ = 10 V	30	26.5 nC			
	0.018 at V $_{ m GS}$ = 4.5 V	25	20.5 IIC			

FEATURES

- Halogen-free
- TrenchFET[®] Power MOSFET
- 100 % R_g and UIS Tested •

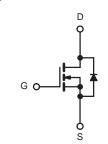
APPLICATIONS

- DC/DC Conversion
 - Low-Side Switch
- Notebook PC
- Gaming •



DFN 3x3 EP

	Top View		
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N-Channel MOSFET

ABSOLUTE MAXIMUM RATIN	IGS T _A = 25 °C,	unless other	wise noted		
Parameter		Symbol	Limit	Unit	
Drain-Source Voltage		V _{DS}	30	V	
Gate-Source Voltage		V _{GS}	± 20		
	T _C = 25 °C		30		
Continuous Drain Current (T _{.1} = 150 °C)	T _C = 70 °C		22.6		
	T _A = 25 °C		21.5 ^{b, c}		
	T _A = 70 °C	1	17.1 ^{b, c}	Α	
Pulsed Drain Current		I _{DM}	100	A	
Continuous Source-Drain Diode Current	T _C = 25 °C	I _S	13		
Continuous Source-Drain Diode Current	T _A = 25 °C	'S	3.1 ^{b, c}		
Single Pulse Avalanche Current	L = 0.1 mH	I _{AS}	10		
Avalanche Energy		E _{AS}	5	mJ	
	T _C = 25 °C		16.7		
Maximum Power Dissipation	T _C = 70 °C	P _D	10.7	w	
	T _A = 25 °C		3.7 ^{b, c}	~~~	
	T _A = 70 °C	1 [2.4 ^{b, c}		
Operating Junction and Storage Temperature Range		T _J , T _{stg}	- 55 to 150	°C	

THERMAL RESISTANCE RATINGS						
Parameter		Symbol	Typical	Maximum	Unit	
Maximum Junction-to-Ambient ^{b, d}	t ≤ 10 s	R _{thJA}	27	34	°C/W	
Maximum Junction-to-Foot (Drain)	Steady State	R _{thJF}	6	7.5	0/11	

Notes:

a. Based on $T_C = 25 \text{ °C}$. b. Surface Mounted on 1" x 1" FR4 board.

c. t = 10 s.

d. Maximum under Steady State conditions is 85 °C/W.



Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit	
Static		•			•		
Drain-Source Breakdown Voltage	V _{DS}	V _{GS} = 0 V, I _D = 1 mA	30			V	
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	1 050 11		27			
V _{GS(th)} Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	I _D = 250 μA		- 5.6		mV/°C	
Gate-Source Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}$, $I_D = 250 \ \mu A$	1.0		3.0	V	
Gate-Source Leakage	I _{GSS}	$V_{DS} = 0 V, V_{GS} = \pm 20 V$			± 100	nA	
	I _{DSS}	$V_{DS} = 30 \text{ V}, V_{GS} = 0 \text{ V}$			1	μΑ	
Zero Gate Voltage Drain Current		V _{DS} = 30 V, V _{GS} = 0 V, T _J = 55 °C			10		
On-State Drain Current ^a	I _{D(on)}	$V_{DS} \ge 5 V, V_{GS} = 10 V$	30			А	
		V _{GS} = 10 V, I _D = 15 A		0.010		Ω	
Drain-Source On-State Resistance ^a	R _{DS(on)}	V _{GS} = 4.5 V, I _D = 10 A		0.018			
Forward Transconductance ^a	g _{fs}	V _{DS} = 15 V, I _D = 15 A		75		S	
Dynamic ^b				1	I		
Input Capacitance	C _{iss}			650			
Output Capacitance	C _{oss}	V _{DS} = 15 V, V _{GS} = 0 V, f = 1 MHz		236		pF	
Reverse Transfer Capacitance	C _{rss}			20			
	Qg	V _{DS} = 15 V, V _{GS} = 10 V, I _D = 10 A		10	20	nC	
Total Gate Charge				4.5	9		
Gate-Source Charge	Q _{gs}	V _{DS} = 15 V, V _{GS} = 4.5 V, I _D = 10 A		2.1			
Gate-Drain Charge	Q _{gd}			0.7			
Gate Resistance	R _g	f = 1 MHz	0.2	1.1	2.2	Ω	
Turn-On Delay Time	t _{d(on)}			8	16		
Rise Time	t _r	$V_{DD} = 15 \text{ V}, \text{ R}_{L} = 1.5 \Omega$		16	30	- ns	
Turn-Off Delay Time	t _{d(off)}	$I_D \cong 10$ A, V_{GEN} = 4.5 V, R_g = 1 Ω		17	35		
Fall Time	t _f			7	15		
Turn-On Delay Time	t _{d(on)}			14	30		
Rise Time	t _r	$V_{DD} = 15 \text{ V}, \text{ R}_{L} = 1.5 \Omega$		50	100		
Turn-Off Delay Time	t _{d(off)}	$I_D \cong 10 \text{ A}, \text{ V}_{\text{GEN}} = 10 \text{ V}, \text{ R}_{\text{g}} = 1 \Omega$		16	30		
Fall Time	t _f			8	18		
Drain-Source Body Diode Characteristi	cs			•	<u>1</u>	I	
Continuous Source-Drain Diode Current	۱ _s	T _C = 25 °C			13		
Pulse Diode Forward Current ^a	I _{SM}				100	A	
Body Diode Voltage	V _{SD}	I _S = 3 A		1	1.2	V	
Body Diode Reverse Recovery Time	t _{rr}	-			40	ns	
Body Diode Reverse Recovery Charge	Q _{rr}				20	nC	
Reverse Recovery Fall Time	t _a	I _F = 10 A, dl/dt = 100 A/μs, T _J = 25 °C		12.5			
Reverse Recovery Rise Time	t _b	1		7.5	1	ns	

a. Pulse test; pulse width \leq 300 $\mu s,$ duty cycle \leq 2 %

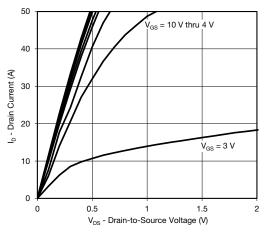
b. Guaranteed by design, not subject to production testing.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

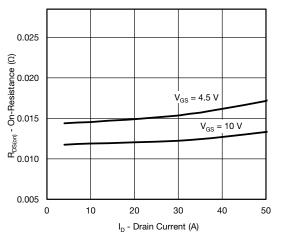
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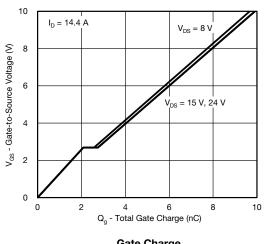
TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



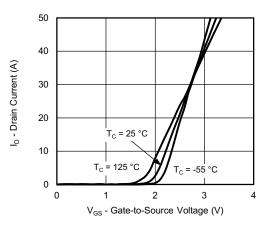
Output Characteristics



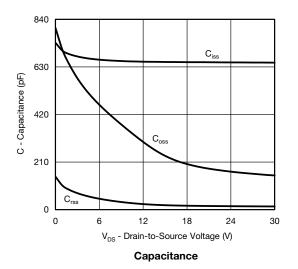
On-Resistance vs. Drain Current

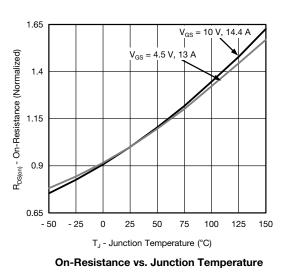


Gate Charge



Transfer Characteristics

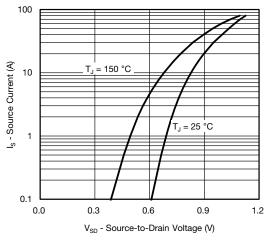




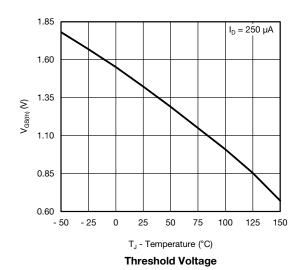
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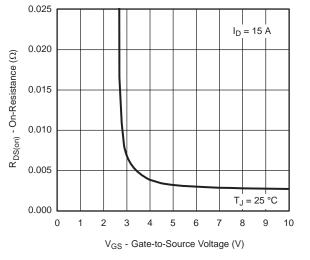


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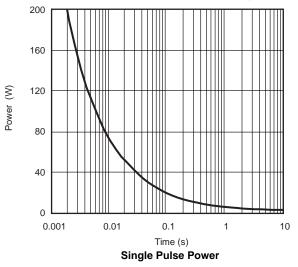


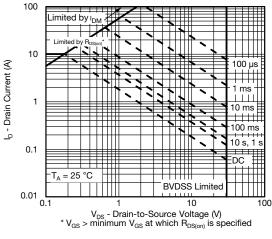
Source-Drain Diode Forward Voltage





On-Resistance vs. Gate-to-Source Voltage

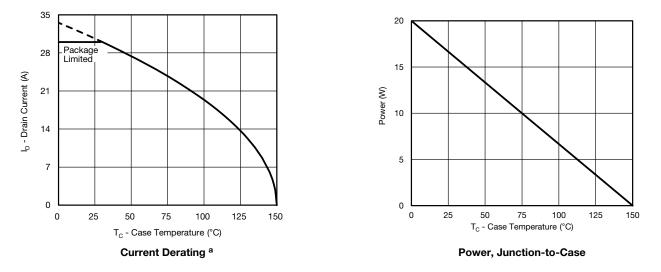




Safe Operating Area, Junction-to-Ambient



TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

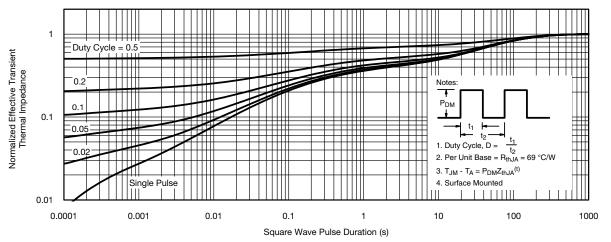


Note

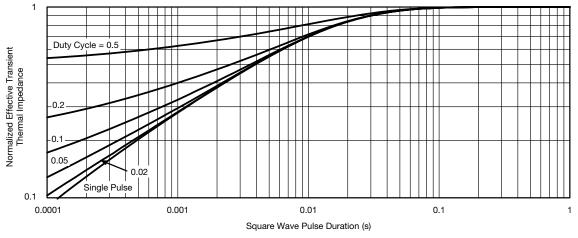
a. The power dissipation P_D is based on T_J max. = 25 °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.



TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

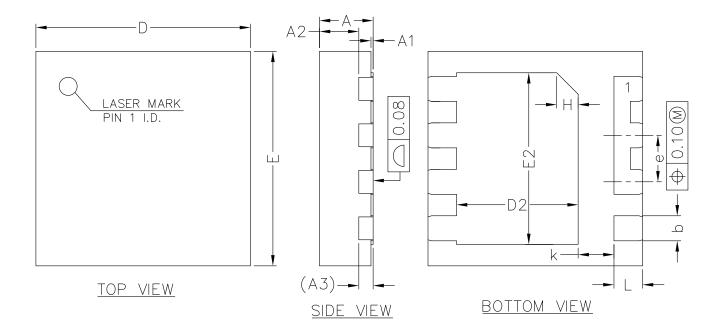


Normalized Thermal Transient Impedance, Junction-to-Ambient



Normalized Thermal Transient Impedance, Junction-to-Case







<u>SIDE VIEW</u>

SYMBOL	MIN	NOM	MAX			
А	0.70	0.75	0.80			
A1	0.00	0.02	0.05			
A2	0.50	0.55	0.60			
A3	0.20REF					
b	0.30	0.35	0.40			
D	2.90	3.00	3.10			
E	2.90	3.00	3.10			
D2	1.60	1.70	1.80			
E2	2.30	2.40	2.50			
е	0.55	0.65	0.75			
К	0.40	0.50	0.60			
L	0.35	0.40	0.45			

COMMON DIMENSIONS (UNITS OF MEASURE=MILLIMETER)



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